

00684.003547

PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:)	
	:	Examiner: Unassigned
SEIJI TAKEUCHI, ET AL.)	
	:	Group Art Unit: Unassigned
Application No.: 10/733,359)	
	:	
Filed: December 12, 2003)	
	:	
For: METHOD AND APPARATUS FOR)	
MEASURING BIREFRINGENCE	:	February 18, 2004

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Sir:

In compliance with the duty of disclosure under 37 C.F.R. § 1.56 and in accordance with the practice under 37 C.F.R. §§ 1.97 and 1.98, the Examiner's attention is directed to the documents listed on the enclosed Form PTO-1449. Copies of the listed foreign patent documents and non-patent publications are also enclosed.

Many of the listed documents (including all of the foreign language documents) are discussed in the specification at pages 1 and 2. Applicants submit that the foreign language documents are relevant for the reasons noted therein. In addition, Applicants have obtained from a commercial database an English language abstract for Japanese Application No. 8-201175, a copy of which is enclosed for the Examiner's convenience.

FORMAL MATTERS


No fee is believed due in connection with this paper; however, if any fee is due, it should be charged to Deposit Account No. 06-1205. A duplicate of this paper is enclosed for that purpose.

CONCLUSION

It is respectfully requested that the above information be considered by the Examiner and that a copy of the enclosed Form PTO-1449 be returned indicating that such information has been considered.

Applicants' undersigned attorney may be reached in our Washington D.C. office by telephone at (202) 530-1010. All correspondence should continue to be directed to our address given below.

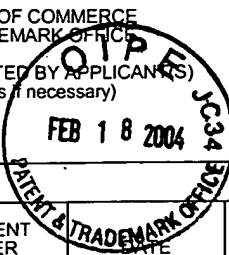
Respectfully submitted,



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JJO/tmm

FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) Date Submitted: February 18, 2004				ATTY DOCKET NO. 00684.003547		APPLICATION NO. 10/733,359	
				APPLICANT SEIJI TAKEUCHI, ET AL.			
				FILING DATE December 12, 2003		GROUP Unassigned	

U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
		5,298,972	03/29/94	Heffner			
		5,517,589	05/14/96	Takeuchi			

FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
		05-209791	08/1993	Japan			No
		0 536 538	04/1993	Europe			
		08-201175	08/1996	Japan			Abstract

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)	
	Umeda, et al., "Measurement of the Residual Birefringence Distribution in Glass Laser Disk by Transverse Zeeman Laser", Electronics and Communication in Japan, Part 2, Vol. 74, No. 5, pp. 21-28 (1991).
	Wang, et al., "A New Instrument for Measuring Both the Magnitude and Angle of Low Level Linear Birefringence," Review of Scientific Instruments, Vol. 70, No. 10, pp. 3847-3854 (1999).

EXAMINER	DATE CONSIDERED
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Sheet 1 of 1

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Form #62

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